EID1416A1-8

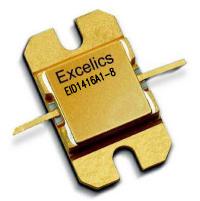


UPDATED 09/20/2007

14.0-16.0GHz 8-Watt Internally-Matched Power FET

FEATURES

- 14.0-16.0GHz Bandwidth
- Input/Output Impedance Matched to 50 Ohms
- +39.5 dBm Output Power at 1dB Compression
- 6.0 dB Power Gain at 1dB Compression
- 27% Power Added Efficiency
- 100% Tested for DC, RF, and R_{TH}



Caution! ESD sensitive device.

ELECTRICAL CHARACTERISTICS ($T_a = 25^{\circ}C$)

SYMBOL	PARAMETERS/TEST CONDITIONS ¹	MIN	ТҮР	MAX	UNITS
P _{1dB}	Output Power at 1dB Compression f = 14.0-16.0GHz V _{DS} = 10V, $I_{DSQ} \approx 2200$ mA	38.5	39.5		dBm
G _{1dB}		5.0	6.0		dB
ΔG	Gain Flatnessf = 14.0-16.0GHz V_{DS} = 10V, $I_{DSQ} \approx 2200$ mA			±0.6	dB
PAE	Power Added Efficiency at 1dB Compression V_{DS} = 10V, $I_{DSQ} \approx 2200$ mAf = 14.0-16.0GHz		27		%
Id _{1dB}	Drain Current at 1dB Compression f = 14.0-16.0GHz		2800	3600	mA
I _{DSS}	Saturated Drain Current $V_{DS} = 3 V, V_{GS} = 0 V$		4200	5760	mA
V _P	Pinch-off Voltage V_{DS} = 3 V, I_{DS} = 40 mA		-1.2	-2.5	V
R _{TH}	Thermal Resistance ²		3.5	4.0	°C/W

Note: 1. Tested with 100 Ohm gate resistor.

2. S.C.L. = Single Carrier Level.

3. Overall Rth depends on case mounting.

ABSOLUTE MAXIMUM RATING FOR EFE

SYMBOLS	PARAMETERS	ABSOLUTE ¹	CONTINUOUS ²	
Vds Drain-Source Voltage		15V	10V	
Vgs Gate-Source Voltage		-5V	-4V	
lgf	Forward Gate Current	96mA	28.8mA	
lgr	Reverse Gate Current	-19.2mA	-4.8mA	
Pin	Input Power	38.5dBm	@ 3dB Compression	
Tch Channel Temperature		175C	175C	
Tstg Storage Temperature		-65C to +175C	-65C to +175C	
Pt	Total Power Dissipation	38W	38W	

Note: 1. Exceeding any of the above ratings may result in permanent damage.

2. Exceeding any of the above ratings may reduce MTTF below design goals.



EID1416A1-8

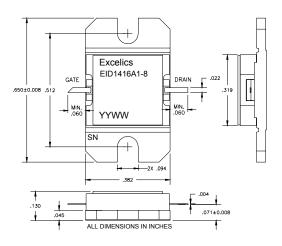
UPDATED 09/20/2007

14.0-16.0GHz 8-Watt Internally-Matched Power FET

PACKAGES OUTLINE

Dimensions in inches, Tolerance <u>+</u> .005 unless otherwise specified

EID1416A1-8 (Hermetic)





Caution! ESD sensitive device.

ORDERING INFORMATION

Part Number	Packages	Grade ¹	f _{Test} (GHz)	P _{1dB} (min)
EID1416S1-8	Hermetic	Industrial	14.0-16.0GHz	38.5

Notes: 1. Contact factory for military and hi-rel grades.

2. Exact test conditions are specified in "Electrical Characteristics" table.

DISCLAIMER

EXCELICS SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. EXCELICS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN.

LIFE SUPPORT POLICY

EXCELICS SEMICONDUCTOR PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF EXCELICS SEMICONDUCTOR, INC. AS HERE IN:

 Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.
A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness